Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/084,252	YANO ET AL.
Examiner	Art Unit
Mark A Mais	2664

SEARCHED				
Class	Subclass	Date	Examiner	
370	312 328 331	11/29/2005	MAM	
	338 349			
	395.21			
	395.52			
	389 400	·		
	401			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Talked to Wellingon Chin	11/29/2005	МАМ	
See Attached Electronic Search	11/29/2005	МАМ	